



ID de la contribución : 856

Tipo : no especificado

Study of the performance of different monolithic and pixelated scintillation crystals for Compton imaging

martes, 19 de noviembre de 2024 17:54 (10)

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Abstract

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Primary author(s) : ESCALANTE-CASTRO, J.M. (IFIC-CSIC)

Co-author(s) : ALBIOL, F.J.; TORTAJADA, S.; CABALLERO, L.

Presenter(s) : ESCALANTE-CASTRO, J.M. (IFIC-CSIC)

Clasificación de la sesión : Transferencia de Tecnología

Clasificación de temáticas : Transferencia Tecnología